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| OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.) | | | | | | | | |
| Jun YAMAUCHI, et al., "First-Principles Study on Indium atoms in Silicon", 26th INTERNATIONAL CONFERENCE ON | | | | | | | | |
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| | AZ | | Additional References sheet(s) attached | | | | | |
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| *Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. | | | | | | | | |